### **RESEARCH PAPER**

# Realization of a 30-W highly efficient and linear reconfigurable dual-band power amplifier using the continuous mode approach

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This paper presents the design methodology and the realization of a highly linear and power-efficient reconfigurable dualband amplifier based on the continuous/Class-ABJ approach. The Class-ABJ theory allows presenting different reactive solutions on both fundamental and second harmonic terminations compared with the standard Class-AB mode. Despite the various terminations, a constant optimum output performance in terms of power, gain, and efficiency can still be achieved. The output impedances are then translated into frequency thus allowing the realization of broadband power amplifiers (PAs) at high-power level of 30 W. In this work, the Class-ABJ broadband approach will be used for the realization of a reconfigurable dual-band power amplifier operating in the two frequency bands 2.1–2.2 and 2.5–2.6 GHz. Continuous wave (CW) measurements on the realized PA show power and efficiency greater than 17 W and 55% in the two frequency bands with peak values up to 30 W and 63.7%. Indeed, it is shown that such novel modes can be predistorted and therefore the linearity requirement can also be met.

Keywords: Power amplifiers and linearizers, Circuit design and applications

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### I. INTRODUCTION

Power amplifiers (PAs) used in macro base stations have so far been realized with the aim of delivering high power (>50 W) [1] in order to cover a wider area as possible for mobile phone communications. However, the wireless industry community is moving toward the realization of smaller base stations closer to the mobile users called "Pico" or "Femto" base stations [1, 2]. Small base stations would deliver lower RF power with the consequent disadvantages of covering smaller area. This can however be overcome by placing a greater number of base stations in trafficked areas as in city centers and a minor number in non-trafficked areas as countryside. However, in order to perform the high-powerefficiency states also for the wideband spectrum frequency for the upcoming wireless communication standards new approaches must be considered. From here, dual-band/multiband [3-11] and broadband [12-14] PAs are in continuous development for RF/wireless applications. One approach

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that has been under attention in the last few years is called continuous modes [15, 16], which is related to the Class-J theory. Here by moving the fundamental drain impedance from its optimum point, it is possible to restore the high-power-efficiency state by proper adjustment of the higher harmonics.

This paper presents the design methodology and the realization of a reconfigurable dual-band PA at 2.1–2.2 and 2.6–2.7 GHz at high-power level of 30 W using the continuous/Class-ABJ approach [17]. The paper highlights the fact that thanks to the flexibility of the continuous-mode solutions broadband and multiband PAs can be easily realized with delivering high-power efficiency still satisfying the linearity requirement, both in a trade-off with bandwidth, of modern communication standards in now different targeted frequency bands. Furthermore, for the first time it will be seen that by matching the reactive Class-BJ solutions to the standard 50  $\Omega$  characteristic impedance, no matching degradation are in theory introduced.

#### II. THEORETICAL CLASS B/J/BJ MODES

This Section shortly explains in theory the difference between the standard Class-B [18, 19], the Class-J [18, 20], and Class-BJ PA modes for broadband operation [15]. Equations (1) and (2) describe the Classes B/J/BJ current and voltage waveforms:

$$i_{B/J/BJ}(\vartheta) = I_1 \cos(\vartheta) \quad \begin{cases} 0 < \vartheta < \pi/2 \\ (3/2)\pi < \vartheta < 2\pi \end{cases}$$

$$= 0 \qquad \pi/2 < \vartheta < (3/2)\pi, \qquad (1)$$

 $v_{\rm B/J/BJ}(\vartheta) = V_{\rm DC} \cdot \left(1 - V_1 \cos \vartheta - \delta \sin \vartheta + \frac{\delta \cdot V_1}{2} \sin 2\vartheta\right). (2)$ 

Note that while the current waveform is supposed in theory to remain constant for the different modes, the voltage waveform varies as a function of  $\delta$ . The classes B, J, and BJ voltage waveforms are achieved for  $\delta = 0$ ,  $\delta = 1$ , and  $-1 < \delta < 1$ , respectively. These new voltage waveforms named *family of continuous voltage waveforms* as well as the various impedances are displayed in Fig. 1.

These new waveforms and therefore new solutions will all deliver the same power-efficiency performance. This is due to the fact that as noted from (2) the variation of  $\delta$  will only vary the sin terms (imaginary parts) of fundamental and second harmonic voltage components. Therefore, being the cos terms (real parts) and the DC component constant, the power and the efficiency will be kept optimum invariant function of  $\delta$ , as explained in details here [15, 16].

It is very important to highlight that the parameter  $\delta$  has to vary between -1 and 1 in order to keep the voltage waveforms positive or grazing the zero value for  $\delta = \pm 1$  [15]. If  $\delta$  goes beyond that range, the voltage waveforms drop lower than zero, as highlighted in yellow in Figure 2 where  $\delta = \pm 1.1$ , with consequently nonlinear behavior accompanied in reduction of power and efficiency.

Another aspect to take into account is the knee voltage  $V_{knee}$  [18, 21]. Figure 3 shows the voltage and current waveforms as well as the load-lines for the Class-B mode when varying the knee voltage. Supposing a normalized fundamental voltage and current components both equal to 1, when  $V_{knee} =$  o the ideal class-B case is presented with the half-wave rectified sinusoidal current waveform (blue trace) and the sinusoidal voltage waveform (red trace).



Fig. 2. Theoretical Class-BJ voltage waveforms for  $\delta = o$  (red line) and for  $\delta = \pm 1.1$  (green and blue lines).

In the case  $V_{knee} > 0$ , the current waveform  $I_d$  will vary as a function of  $V_{knee}$ , as shown in equation (3) [18]:

$$I_d = v_g \cdot g_m \cdot I_{\max} \left( 1 - e^{-\left(\frac{v_{ds}}{V_{knee}}\right)} \right).$$
(3)

As also noted from Fig. 3, such current waveforms will present some troughs. This compression is due to the fact that in this case it is assumed that the voltage waveform remains constant sinusoidal (with  $V_1 = 1$ , where  $V_{MAX} = 2$  being  $V_{DC} = 1$ ). Therefore, when considering such  $V_{knee} > 0$ , the minimum allowed voltage value where the device act as a current source is greater than zero. Therefore, with  $V_{knee} > 0$  and considering/enforcing the voltage to be sinusoidal (between 0 and 2 V) the device is enforced to go inside its knee/compression region (in this case to the minimum V = I = 0), as clearly shown in both plots of Fig. 3.

Figure 4 shows the efficiency behavior function of the knee voltage under the previous assumption. For  $V_{knee} = 0$  the standard efficiency value of 78.5% is obtained. When increasing the  $V_{knee}$  to 0.1 V the efficiency decreases to about 68%. Increasing such  $V_{knee}$  value it can be seen that the efficiency decreases, dropping down to about 64% for  $V_{knee}$  equal to 0.2 V.



Fig. 1. Theoretical Class-B/J/BJ current (blue) and voltage (red) waveforms for  $\delta$  varying between -1 and 1 in steps of 0.2 (left figure); as well as fundamental and second harmonic terminations (right figure).



Fig. 3. Class-B voltage and current waveforms (left Fig.) and load-line (right Fig.) both function of  $V_{knee}$ .

### III. MATCHING THE REACTIVE CLASS-J LOAD TO 50 $\Omega$

In the literature review [22], it is shown how to match a real impedance  $R_S$  to another real impedance  $R_L$  (i.e.  $R_L = 50 \Omega$ ) using different networks and techniques, for example RLC networks or transmission/ $\mu$ strip lines [22].

In this paragraph, it will be seen in theory how to match a reactive source impedance

$$Z_{\rm S} = R_{\rm S} + j \times X_{\rm S},\tag{4}$$

where

$$R_S = X_S \tag{5}$$

with the assumption of considering high-power transistors (i.e. 30 W) for which

$$R_{\rm S} \le 25\,\Omega\tag{6}$$

to the environment system impedance of 50  $\Omega$  using a simple lossless LC low-pass filter network. Supposing to work at the device intrinsic plane, the aim of this paragraph is to show that when considering the Class-J reactive impedance, the matching of such solution to the characteristic impedance is not degraded compared with the standard real impedance case.

It is known [22] that when the reactive part  $X_S = 0$ , an LC low-pass filter (series-*L* and parallel-*C* and supposing a loss less network R = 0) can be used to match the input/source impedance ( $Z_S$ ) to the load impedance  $Z_L = 50 \Omega$ .



Fig. 4. Class-B efficiency function of the knee voltage.

In this case

$$C_{Real} = \frac{1}{\omega \cdot R_L} \cdot Q, \tag{7}$$

$$L_{Real} = \frac{C_{Real} \cdot R_L}{n},\tag{8}$$

where  $C_{Real}$  and  $L_{Real}$  are the values of the inductance and capacitance when considering only a real component. Where Q is the quality factor achievable by

$$Q = \sqrt{n-1} \tag{9}$$

and n is the ratio between the real part of the load impedance and the real part of the input/source impedance

$$n = \frac{R_L}{R_S}.$$
 (10)

When considering the Class-J impedance in accordance with (4) and (5) and supposing  $R_S \le 25 \Omega$  (high-power device case), the parameters Q and n are equal to the previous case as well as the capacitor value will remain equal to (7) while the series inductor of (8) now termed  $L_I$  will be

$$L_I = L_{Real} - L_{ADD},\tag{11}$$

where

$$L_{ADD} = \frac{X_S}{\omega} \tag{12}$$

is the addition inductance value due to the reactive Class-J load, with  $\omega = 2 \pi f$ , where *f* is the operating frequency.

Figure 5 shows the *C* and *L* values function of the source resistance  $R_S$  when  $X_S = o$  and when  $R_S = X_S$  carried out at frequency F = 2.1 GHz in order to match the different impedances to the characteristic 50  $\Omega$  load. Noted that the capacitor C (red line) presents the same value for the two cases  $X_S = o$  and  $X_S = R_S$  and it decreases when increasing  $R_S$ . The inductor *L* presents different behavior for  $X_S = o$  (blue line) and  $X_S = R_S$  (green line). For  $X_S = o$  such inductor value needs to increase with increasing  $R_S$ , while when considering the Class-J solutions  $X_S = R_S$  such *L* presents smaller values



**Fig. 5.** Capacitance and inductance values function of  $R_s$  when  $X_s = 0$ .

compared with case  $X_S = 0$  and it decreases with increasing  $R_S$ . Between the solution  $X_S = o$  (blue trace) and the Class-J extreme solution  $X_S = R_S$  (green trace) there are infinite solutions (intermediate continuous solutions) function of the parameter  $\delta$  as explained in Section II. Varying the parameter  $\delta$  the reactive part  $X_S$  will vary and therefore in accordance with (12)  $L_{ADD}$  will vary too leading to different  $L_I$  in order to allow the matching condition. In both cases when  $X_S = 0$  and  $X_S = R_S$ , the parameter *n* remains constant (being n the ratio of the only real parts as stated in (10)) as well as the quality factor and they both decrease with increasing  $R_S$  as shown in Fig. 6. This leads to the conclusion that for high-power devices (for the case where the fundamental load is less than 25  $\Omega$ ) when matching the Class-J fundamental impedance (achieved at the device intrinsic plane) to the 50  $\Omega$  characteristic impedance using an LC network, or using more resonant networks depending of Q and  $R_S$ , such reactive solutions do not degrade the matching quality compared with standard Class-B (only resistive) mode. Therefore, supposing to have a highly reflective second harmonic termination with the appropriate phase adjustment function of the reactive fundamental termination (in accordance with the Class-J theory), broadband PAs can be realized without output performance degradation due to the matching networks.



**Fig. 6.** Q and n functions of  $R_s$ .

IV. DUAL-BAND PA DESIGN STEPS - SIMULATIONS

# A) Using the Class-ABJ theory for the realization of a reconfigurable dual-band power amplifier – considerations

The appropriate Class-ABI impedance terminations can be presented by designing the appropriate output matching network (OMN). However, it is known that in practical PA implementation, the realization of such networks following the load traces of Fig. 1 for both fundamental and second harmonic impedances in a simultaneous way is challenging. This becomes more challenging when dealing with very high-power devices for which the fundamental optimum impedance is near to the short-circuit point. Furthermore, the analysis presented in the previous section has shown the right impedances to present at the intrinsic device plane thus frequency independent. When shifting it at the extrinsic plane thus dealing with packaged devices the right impedances must obviously be presented at the package plane and thus frequency dependent. Previous works have shown very well-performed broadband Class-BJ or continuous PAs [20, 23, 24].

Another way to use the Class-BJ theory is to realize multiband PAs. In this paper, the continuous/Class-ABJ theory has been used to realize a reconfigurable dual-band PA working in the two frequency ranges 2.1–2.2 and 2.6–2.7 GHz. In a few words, the continuous Class-BJ approach has been applied in the overall frequency range 2.1–2.7 GHz, with focusing on the two extremes of the overall band. Therefore, during the design of the OMN, tedious simulations have been avoided in the middle band 2.2–2.5 GHz focusing and optimizing the two extreme targeted bands 2.1–2.2 and 2.6–2.7 GHz.

#### **B)** Class-AB simulations

The Class-ABJ PA has been designed using Computer-Aided Design (CAD) Advanced Design System (ADS) simulations and the accurate AlGaN/GaN power transistor model developed in [26] with gate width of 9.6 mm and gate length of 0.5  $\mu$ m [25, 26].

Before the Class-ABJ can be investigated/designed, the standard singular solution Class-AB mode must be achieved. At fundamental frequency F = 2.4 GHz and drain bias voltage  $V_D = 40$  V, by following the design procedure of [27], input power, gate bias, and fundamental and second harmonic impedances are properly swept in order to achieve the best Class-AB trade-off between power, efficiency, and gain. Best performance is achieved for  $V_G = -1.64$  V, where  $I_{dq} = 70$  mA with the fundamental and second harmonic impedances as shown in Fig. 7(a). The harmonic impedances higher than two are considered short-circuited. Figure 7(b) shows the Class-AB output performance in terms of power, efficiency, and gain function of the input power sweep. Maximum drain efficiency (DE) of 64.9% with gain of 21.3 dB, while delivering 44.6 dBm of output power has been achieved.

### C) Class-ABJ simulations

Once established the starting Class-AB state, the theory presented in Section II has been applied and the Class-ABJ performance has been carried out. The standard Class-AB mode



Fig. 7. Simulated standard Class-AB DE, output power and gain function of the input power sweep.

achieved in previous Section is the  $\delta = o$  solution of the Class-BJ mode. Therefore, by varying the parameter  $\delta$ , various voltage waveforms (with maintaining a fixed current waveform) have been carried out leading to different load solutions as shown in Figs 8 and 9. Here the parameter  $\delta$  has been varied in the range -1-0. The positive range (0-1) has initially not been taken into account due to stability considerations. Being the input transistor side still not optimized, at this stage the PA can present stability issues for some impedance terminations. Such issues have been overcome in the design of the input matching network (IMN) and the input bias network as then shown in Section IV D. The Class-ABI fundamental and second harmonic impedances have been carried out at both intrinsic device plane and measurement plane, are shown in Fig. 8. The simulated Class-ABJ voltage and current waveforms are shown in Fig. 9, whereas the output power and DE function of  $\delta$  are shown in Table 1. From such Table 1 it can be observed that when decreasing  $\delta$  the power presents a 1.7 dB degradation from 44.6 to 42.9 dBm, while the efficiency presents some improvement from 64.9 to 65.7%.

# D) Class-ABJ output & input matching networks

Once the Class-ABJ fundamental and second harmonic terminations have been identified and the output performance satisfies the high-power efficiency target, the next stage is the actual OMN design. The design of the OMN is not an easy task for high-power devices due to the low optimum impedance (close to zero). This becomes more challenging for wide band frequencies. It is important to highlight again that in Section IV C, the various impedances (function of  $\delta$ ) have been carried out for the fixed frequency F = 2.4 GHz, while here the possibility of new impedance solutions (as shown in Fig. 8) allow to accommodate different optimum frequency solutions when designing the OMN. Therefore, with this approach, high-power efficiency and now broadband as well as multi-band PAs can be realized. The dual-band Class-ABJ OMN capable of synthesizing the impedances of Fig. 8 is shown in the schematic of Fig. 10, whereas Fig. 11 shows the S11 behavior (green trace) of the OMN of Fig. 10 as well as the target simulated impedances (red dots). Noted that for the fundamental impedances, which means for the two frequency ranges 2.1-2.2 and 2.6-2.7 GHz (highlighted in the zoomed window of Fig. 11), the simulated OMN S11 green trace fits properly with the targeted continuous mode impedance points whereas in the not of interest band (about 2.2-2.5 GHz) the green trace does not fit with the impedance (blue dot), as highlighted in the blue area. It is important to highlight that also the second harmonic loads have to be properly matched (in this case) around the edge of the Smith chart with the proper phases in accordance with the continuous mode theory.



Fig. 8. Simulated Class-ABJ  $Z_{Fo}$  (blue) and  $Z_{2Fo}$  (red) carried out at both (a) intrinsic plane and (b) measurement plane for  $\delta = -1, -0.5$ , and o.



Fig. 9. Simulated Class-ABJ voltage (red) and current (blue) waveforms for  $\delta$  varying between -1 and 0 in steps of 0.5.

**Table 1.** Output power and DE function of  $\delta$ .

	$\delta = -1$	$\delta = -0.5$	$\delta = 0$	
Output power (dBm)	42.9	44	44.6	
DE (%)	65.7	65.1	64.9	

The last step of this approach is the design of the IMN in order to minimize the input reflection coefficient by conjugately matching the device input impedance  $Z_{IN} \approx 0.6$ -j2 (where  $Z_{IN}$  presents a small phase variation function of the frequency) to the 50  $\Omega$  source load.

Figure 12 shows the zoomed IMN of the actual Class-ABJ PA photo (the photo of the overall PA is shown in Fig. 14). It can be noted that different resistors have been added for the circuit stabilization. The two resistors on the RF path are  $R_1 = 5 \Omega$  and  $R_2 = 3 \Omega$ . These two resistors have been accurately chosen as small as possible to minimize the gain loss. The resistors on the DC path  $R_3$  and  $R_4$  are respectively equal to 30 and 50  $\Omega$ . Thanks to such IMN design the PA results stable and it has shown about 4–5 dB gain improvement along the entire bandwidth. Once the IMN is designed and thus the PA does not present stability issues, the overall PA can be studied and the output performance can be displayed.

The DE, power-added-efficiency (PAE), output power  $P_{OUT}$  and the nonlinear gain (large signal gain) G are presented in Fig. 13 when driving the device with an input power Pin = 33 dBm corresponding to a compressing point of about 2-3 dB. Here the simulations show an average efficiency of about 64% in both the lower and the upper frequency bands 2.1-2.2 and 2.6-2.7 GHz, respectively. The low band presents a wider and smoother behavior, whereas the upper band presents a sharper behavior where the efficiency drops rapidly to low values at about 2.7 GHz. Both output power and gain are maintained >30 W and 11 dB in the two frequency bands. Note that despite the PA has been designed to work in the two bands 2.1-2.2 and 2.6-2.7 GHz, in the out-of-band frequency range 2.2–2.6 GHz the PA delivers  $P_{OUT}$  > 20 W, DE > 31%, and G > 10 dB.

It is important to highlight that such simulated power and efficiency (as well as then the experimental measurements presented in Section V) have been achieved in a reconfigurable mode, which means that when the low band is "On" the high band is "Off" and vice versa.

#### V. RECONFIGURABLE DUAL-BAND CLASS-ABJ PA FABRICATION AND RESULTS

After the theoretical and simulation analysis, the linear highpower efficiency Class-ABJ PA based on the AlGaN/GaN power transistor with gate width of  $W_G = 9.6$  mm (8 × 6 × 600 µm) and gate length of  $L_G = 0.5$  µm [25] has been realized as shown in Fig. 14. The PA has been fabricated on the Rogers substrate RO4003C with dielectric constant  $\varepsilon_r = 3.3$ and dielectric thickness of 0.51 mm.



Fig. 10. Reconfigurable dual-band Class-ABJ OMN schematic representation.



Fig. 11. Class-ABJ dual-and matching.

# A) CW measurements – efficiency, power and gain

Figure 15 shows the measured DE, PAE, output power, and gain behavior function of frequency when driving the PA with a CW stimulus where the input power is about 33.5 dBm in the frequency range 2.05 < F < 2.25 GHz and 32 dBm in the frequency range 2.45 < F < 2.6 GHz in order to deliver a constant average gain of about 10.5 dB. Here it can be noted that in the low-frequency band the PA behaviors as expected (from simulations) whereas for the upper frequency band the optimum performance is achieved at lower frequency compared with simulations. Now the optimum performance is obtained at about 2.45–2.6 GHz resulting in about 100 MHz shift (toward the low frequency) compared with the design simulations (2.6–2.7 GHz).

Both the output power and gain are maintained between 42.4 and 44.8 dBm and about 10–11 dB, respectively, in the bands 2.05–2.25 and 2.45–2.6 GHz. Furthermore, in both frequency bands the DE is maintained >55% whereas the PAE is >50%. Again, noted that the maximum DE and PAE are: 63.7 and 59.4%, respectively, achieved at 2.54 GHz, whereas the maximum output power is  $P_{OUT} = 44.8$  dBm revealed at

F = 2.08 GHz. This Fig. 15 clearly shows that despite the design requirement was to optimize the power efficiency in the two requested bandwidths, using the Class-ABJ theory, the middle band (about 2.25–2.45 GHz) delivers almost constant output power and gain, whereas the DE is still above 40%, thus not presenting consistent degradations if compared with other different multiband designs as shown in the PAs dual-band State-of-the-Art of Table 2.

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Figure 16 shows the Class-ABJ performance when driving the device in compression (about 2–3 dB compression) function of the drain bias voltage  $V_D$  for the two frequencies F =2.14 GHz (left Fig. 16) and F = 2.54 GHz (right Fig. 16). For F = 2.14 GHz both DE and PAE are constant at about 60 and 53%, respectively, for  $V_D$  varying from 20 to 40 V in steps of 5 V. Here the gain is kept constant at about 9– 10 dB, whereas the output power obviously increases with increasing  $V_D$  from 40 to 44.7 dBm. For F = 2.54 GHz efficiency and PAE increase with increasing the drain voltage from 50 and 42%, respectively, to 63.7 and 60%. Here the gain also presents an increase with increasing  $V_D$  from 7.5 to 11.6 dB.

### B) Measurements under Wideband Code Division Multiple Access (WCDMA) excitation

In this section, the Class-ABJ PA is studied when applying a 5 MHz WCDMA stimulus with 5.4 dB Peak-Average-Ratio (PAR). The output performance has been studied as a function of the input power as well as the drain bias voltage  $V_D$  variations as shown in the contour plots of Fig. 17 for the frequency F = 2.14 GHz and in Fig. 18 for F = 2.54 GHz.

At F = 2.14 GHz (Fig. 17) the high-efficiency state (40–45%) is achieved for high output power (34–37 dBm) and low bias voltage  $V_D$  (14–16 V). Such efficiency decreases when increasing  $V_D$ ; however, still DE values of about 30–32% are achieved at  $V_D = 40$  V, whereas delivering power of 36–38 dBm. This DE contour plot clearly shows that in order to maintain high-efficiency values when backing-off the power for the linearity requirement, the drain supply voltage should be decreased. Such behavior is typical of standard envelope tracking PAs [28]. The gain varies from about 13.6 dB down to about 9.5 dB (in compression) when decreasing  $V_D$ .



Fig. 12. Reconfigurable dual-band Class-ABJ IMN photo.



Fig. 13. Simulated DE (red), PAE (black), output power (blue), and gain (green) function of frequency.



Fig. 14. Photograph of the realized reconfigurable dual-band Class-ABJ PA and AlGaN/GaN powerbar.

At F = 2.54 GHz (Fig. 18), the PA shows the same DE behavior than low frequency. Noted that in this case the highefficiency state is maintained for  $V_D$  values up to 40 V where  $DE \approx 42\%$  whereas for the low frequency the PA has shown values of about 30–32% at  $V_D = 40$  V. For the gain parameter (right Fig. 18), the behavior is again similar to the low-frequency one, where in this case higher values can be achieved up to almost 15 dB in the linear region.

Figure 19 shows the adjacent channel power ratio (ACPR) Low results of the continuous/Class-ABJ PA function of the average output power at 2.14 and 2.54 GHz, respectively. The ACPR High are not shown being ACPR Low and ACPR High symmetrical. Such symmetry between the sidebands implies low memory effects and therefore the possibility of predistortability as it will be shown in Section V C.

The measurements have been carried out by driving the PA with the same 5 MHz WCDMA signal with  $V_{GS} = -1.64$  V and when varying the drain bias voltage  $V_D$  from 14 to 40 V. Such ACPR behavior clearly shows that for both frequencies better linearity performance is achieved for high bias voltage  $V_D$  with lowest ACPR (where delivering high power) values of about -47 dBc at 2.14 GHz delivering  $P_{OUT} \approx 37-38$  dBm and about -42 dBc at 2.54 GHz delivering  $P_{OUT} \approx 36-37$  dBm.

Despite the ACPR values do not reach -45 dBc (which is the required ACPR value for a 5 MHz signal) for some  $V_D$ values for both frequencies; it is important to remind that such output performance is revealed without applying any predistortion technique. It will be seen in the next section that when applying a digital predistortion digital predistortion (DPD), the overall linearity is improved.

### C) DPD and reconfigurable dual-band Class-ABJ frequency spectrum

The linearity requirement can be reached by decreasing the input stimulus as well as by applying different linearization techniques [29]. In this case, for the improvement of the PA linearity, a general DPD technique is used. The linearization



Fig. 15. Measured DE (red), PAE (black), output power (blue), and gain (green) function of frequency.

Ref.	Mode	Freq (GHz)	DE (%)	PAE (%)	P <sub>OUT</sub> (dBm)	G (dB)
3	Е	0.83	-	45.3	20.6	$\sim 8$
		1.8	-	44.7	19.5	$\sim_{3.5}$
3	Е	0.8	-	42.5	22.4	$\sim$ 5.5
		1.7	-	42.6	22.2	$\sim$ 7.2
4	F	1.7	44	20-33	32.8	$\sim_5$
		2.14	61.3	25-50	34.4	$\sim_5$
5	HT	2.45	53	-	33	$\sim$ 5-6
		3.3	46	-	32.5	$\sim$ 5-6
6	AB/J	1.4-1.6	43-48	42-47	36.4-37.3	15.4-18
		3-3.9	41-56	38-52	33.4-37.4	10.8-12
7	E	1.75	$\sim_{79}$	78.4	37.8	$10.7^{*}$
		2.54	${\sim}68$	61.3	36.9	9.8*
8	HC	2.5	-	45	22	8*
		3.5	-	34	20.8	6.8*
9	AB	1.96	59.8	-	$\sim$ 39.2	$\sim_{13.2}$
		3.5	55.1	-	$\sim$ 39.7	$\sim_{10}$
10	HC	1.7	-	58.4	36.7	9.8
		2.14	-	59.9	39.7	10.5
This work	Continuous mode	2.05-2.25	55-59-4	50-53	43.9-44.8	10-10.9
		2.45-2.6	55.3-63.7	50.1-59.4	42.4-43.8	9.8-11.4

Table 2. State-of-the-art of dual-band PAs.

HT, harmonically tuned; HC, harmonically controlled.

\*Calculated Gain having Pout and Pin;  $\sim$  estimated gain from the figures.



**Fig. 16.** Measured DE, PAE,  $P_{OUT}$ , and G for F = 2.14 GHz (left Fig.) and for F = 2.54 GHz (right Fig.) when varying the drain bias voltage  $V_D$  between 20 and 40 V in steps of 5 V.



Fig. 17. Contour plots showing the measured average DE (left Fig.) and average gain (right Fig.) function of the average  $P_{OUT}$  and  $V_D$  at F = 2.14 GHz.



Fig. 18. Contour plots showing the measured average DE (left Fig.) and average gain (right Fig.) function of the average  $P_{OUT}$  and  $V_D$  at F = 2.54 GHz.



Fig. 19. ACPR low function of the average output power for the two center frequencies F = 2.14 GHz (left Fig.) and F = 2.54 GHz (right Fig.).

approach is based on the assumption that the nonlinear transfer characteristic of the RF amplifier can be described by the following equivalent baseband function:

$$y = x \cdot \Gamma_{PA}(|x|), \tag{13}$$

where  $\Gamma_{PA}(|x|)$  represents the non-linear AM–AM and AM– PM transfer characteristic of the amplifier, depending on the input signal magnitude. The complex envelopes of the RF input and output signal are expressed by *x* and *y*, respectively. Introducing  $\Gamma_{PD}(|x|)$  as the complex baseband predistorter gain, depending on the input signal magnitude, and isolating the real PA gain as *M*, it can be described as follows:

$$y = x \cdot \Gamma_{PD}(|x|) \cdot \Gamma_{PA}(|x|) \cdot M.$$
(14)

From (14) it follows that ideal linearization will be achieved when  $\Gamma_{PD}(|x|)\cdot\Gamma_{PA}(|x|) = 1$  for all input signal magnitudes which means that  $\Gamma_{PD}(|x|)$  describes the inverse of the amplifiers nonlinearities.

Figure 20 shows schematically the digital predistortion system including the frequency conversion. The inverse transfer characteristic is built by the predistorter. This system includes the measurement path, which is required for instantaneous control of the PA output.



Fig. 20. Adaptive digital predistortion system.

Such predistortion technique has been applied to the Class-ABJ PA with the spectrum contents shown in Fig. 21 for both frequencies 2.14 and 2.54 GHz with (w) and without (w/o) the use of the predistorter. In both the cases, w and w/o the use of the DPD and as mentioned previously, the PA shows a symmetric behavior in the two sidebands leading to almost the same ACPR values for the lower and upper ACP. For the low-frequency F = 2.14 GHz, when considering the PA w/o the use of any DPD an ACP of about -41 dBc is revealed. When applying the DPD, the linearity is considerably improved with ACP values of about -56. For the high-frequency F = 2.54 GHz, the values of ACP are about -34 and -50 dBc w/o and w the use of the DPD, respectively.



Fig. 21. Spectrum with (blue trace) and without (black trace) applying the DPD at (a) F = 2.14 GHz and (b) F = 2.54 GHz.

 Table 3. Class-ABJ Output Performance With and Without the use of DPD.

	F = 2.14  GHz		F = 2.54  GHz	
	P <sub>OUT</sub> (dBm)	DE (%)	P <sub>OUT</sub> (dBm)	DE (%)
Without DPD With DPD	38.5 38.7	30.9 32.6	38.6 38.6	38.5 38.5

Table 3 shows the PA output performance in terms of DE and  $P_{OUT}$  again related to the PA behavior w and w/o the use of the DPD. Note that for F = 2.14 GHz the output power and DE before and after applying the DPD are quite close to each other. In the high band, F = 2.54 GHz both output power and DE are maintained perfectly constant.

### VI. CONCLUSION

This paper has presented the design steps and the physical realization of a reconfigurable dual-band 2.05-2.25 and 2.45-2.6 GHz single stage PA based on the continuous/ Class-ABJ theory. The realized PA delivers efficiency >55% on both bands with maximum peak up to 63.7% as well as high output power >42.4 dBm with maximum peak value up to 44.8 dBm (30 W) under CW stimulus. Furthermore, the PA has shown satisfactory power efficiency and linearity performance when driving it with a 5 MHz WCDMA signal. Here, after applying DPD, the PA delivers an average efficiency of about 32 and 38.5% and average power of about 38.5 dBm with ACPR of -56 and -50 dBc at the centre frequency of the two bands 2.14 and 2.54 GHz, respectively. The results of the Class-ABJ PA have shown that by proper fundamental and harmonic impedance matching, a single-stage PA can deliver power and efficiency results comparable to the standard Class-AB but now for multiple frequency bands.

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